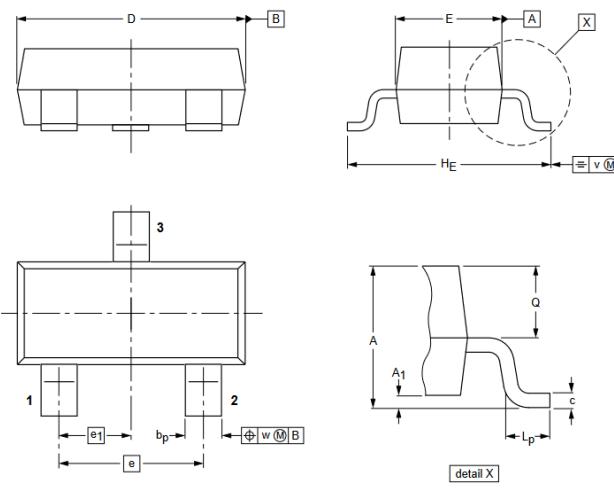


N-Channel MOSFET

Primary characteristics			
Symbol	Parameter	Value	Unit
I_D	Continuous drain current (@ $T_a=25^\circ\text{C}$)	170	mA
V_{DS}	Drain source voltage	100	V
$R_{DS(on)}$ @ $V_{GS}=4.5\text{V}$, $I_D=170\text{mA}$	Static drain-source on-resistance	<10	Ω

Case dimensions



SOT-23 (TO-236AB)

Unit	A	$A_{1\max}$	b_p	c	D	E	e	e_1	H_E	l_p	Q	v	w
mm	1.0 ±0.1	0.1	0.43 ±0.05	0.12 ±0.03	2.9 ±0.1	1.3 ±0.1	1.9	0.95	2.3 ±0.2	0.3 ±0.15	0.5 ±0.05	0.2	0.1

Absolute maximum ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

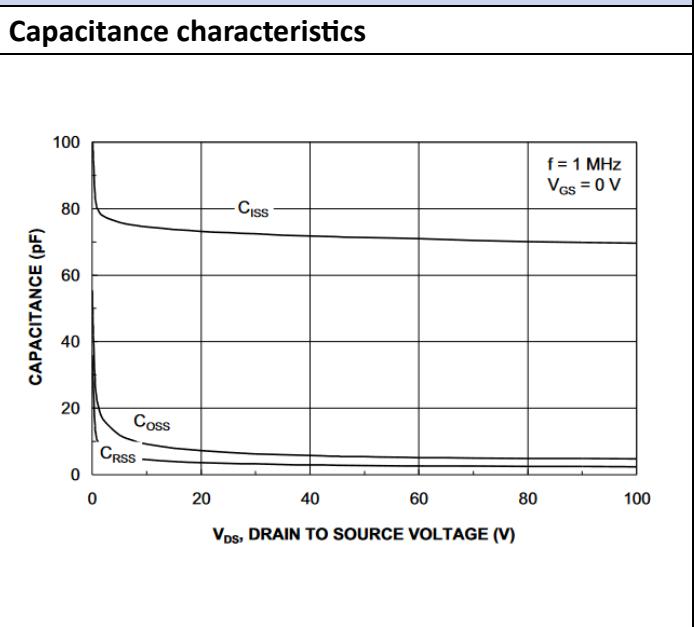
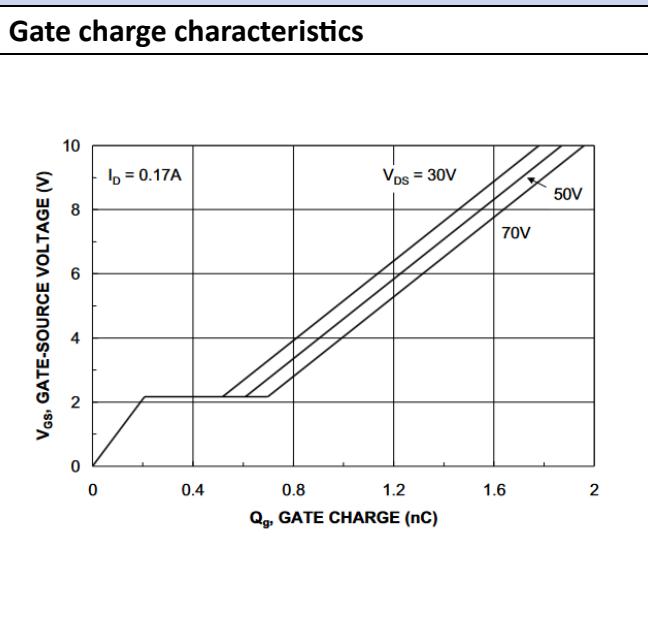
Characteristic	Symbol	Value	Unit
Drain-source voltage	V_{DS}	100	V
Gate-source voltage	V_{GS}	±20	V
Continuous drain current	I_D	170	mA
Pulsed drain current	I_{DM}	680	mA
Power Dissipation	P_D	360	mW
Operating junction temperature range	T_J, T_{STG}	-55 ~ 150	°C
Thermal resistance junction-ambient	$R_{\theta JA}$	350	°C/W
Derate above 25°C		2.8	mW/°C

Electrical characteristics ($T_A = 25^\circ\text{C}$)						
Characteristic	Test condition	Symbol	Value			Unit
			Min.	Typ.	Max.	
Drain-source breakdown voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	V_{DSS}	100	-	-	V
Zero gate voltage drain current	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$	I_{DSS}	-	-	1.0	μA
	$V_{DS}=100\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$		-	-	60	
Gate-body leakage current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	I_{GSS}	-	-	± 10	
Gate threshold voltage	$V_{DS}=V_{GS}, I_D=1.0\text{mA}$	$V_{GS(\text{th})}$	0.8	-	2.8	V
Static drain-source on-state resistance	$V_{GS}=10\text{V}, I_D=170\text{mA}$	$R_{DS(\text{ON})}$	-	-	6.0	Ω
	$V_{GS}=10\text{V}, I_D=170\text{mA}, T_J=125^\circ\text{C}$		-	-	12	
	$V_{GS}=4.5\text{V}, I_D=170\text{mA}$		-	-	10	
On state drain current	$V_{GS}=10\text{V}, V_{DS}=5.0\text{V}$	$I_{D(\text{ON})}$	680	-	-	mA
Dynamic electrical characteristics						
Characteristic	Test condition	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward transconductance	$V_{DS}=10\text{V}, I_D=170\text{mA}$	g_{FS}	0.08	-	-	S
Input capacitance	$V_{DS}=25\text{V}$ $V_{GS}=0\text{V}$ $f=1.0\text{MHz}$	C_{iss}	-	73	-	pF
Output capacitance		C_{oss}	-	7.0	-	
Reverse transfer capacitance		C_{rss}	-	3.4	-	
Gate resistance	$V_{GS}=15\text{mV}, f=1.0\text{MHz}$	R_g	-	2.2	-	Ω
Total gate charge	$V_{DS}=30\text{V}$ $V_{GS}=10\text{V}$ $I_D=220\text{mA}$	Q_g	-	1.8	2.5	nC
Gate source charge		Q_{gs}	-	0.2	-	
Gate drain charge		Q_{gd}	-	0.3	-	
Switching characteristics						
Characteristic	Test condition	Symbol	Value			Unit
			Min.	Typ.	Max.	
Turn on delay time	$V_{DS}=30\text{V}$ $V_{GS}=10\text{V}$ $I_D=280\text{mA}$ $R_G=6.0\Omega$	$t_{d(\text{ON})}$	-	1.7	3.4	ns
Turn on rise time		t_r	-	9.0	18	
Turn off delay time		$t_{d(\text{OFF})}$	-	17	31	
Turn off fall time		t_f	-	2.4	5.0	
Source drain diode characteristics						
Characteristic	Test condition	Symbol	Value			Unit
			Min.	Typ.	Max.	
Body diode reverse recovery time	$I_F=170\text{mA}, d_i/d_t=100\text{A}/\mu\text{s}$	t_{rr}	-	11	-	ns
Body diode reverse recovery charge		Q_{rr}	-	3.0	-	nC
Maximum body-diode continuous current		I_S	-	-	170	mA
Diode forward voltage	$I_S=340\text{mA}, V_{GS}=0\text{V}$	V_{SD}	-	-	1.3	V

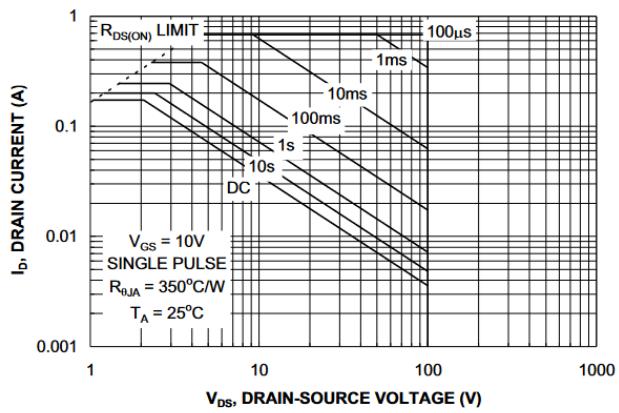
Notes: Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

Typical characteristics	
ON-region characteristics	ON-resistance variation with drain current and gate voltage
<p>Detailed description: A graph showing drain current (I_D) in Amperes versus drain-to-source voltage (V_{DS}) in Volts. Multiple curves are plotted for different gate-to-source voltages (V_{GS}): 2.0V, 2.5V, 3.0V, 3.5V, 4.5V, 6.0V, and 10V. The current increases with both V_{DS} and V_{GS}.</p>	<p>Detailed description: A graph showing normalized drain-source on-resistance versus drain current (I_D). The y-axis is labeled $R_{DS(on)}, \text{NORMALIZED DRAIN-SOURCE ON-RESISTANCE}$. Multiple curves are shown for $V_{GS} = 2.5V, 3.0V, 3.5V, 4.5V, 6.0V, 10V$. The resistance decreases as I_D increases.</p>
ON-resistance variation with temperature	ON-resistance variation with gate-to-source voltage
<p>Detailed description: A graph showing normalized drain-source on-resistance versus junction temperature (T_J). The y-axis is labeled $R_{DS(on)}, \text{NORMALIZED DRAIN-SOURCE ON-RESISTANCE}$. The x-axis ranges from -50°C to 150°C. The resistance increases linearly with temperature.</p>	<p>Detailed description: A graph showing drain-source on-resistance versus gate-to-source voltage (V_{GS}). Two curves are shown for $T_A = 25^\circ\text{C}$ and $T_A = 125^\circ\text{C}$. The resistance decreases as V_{GS} increases, with higher temperatures resulting in higher resistance.</p>
Transfer characteristics	Body diode forward voltage variation with source current and temperature
<p>Detailed description: A graph showing drain current (I_D) versus gate-to-source voltage (V_{GS}). Three curves are shown for $T_A = 125^\circ\text{C}, 25^\circ\text{C}, -55^\circ\text{C}$ at $V_{DS} = 10V$. The current increases with V_{GS} and is higher at higher temperatures.</p>	<p>Detailed description: A graph showing reverse drain current (I_S) versus body diode forward voltage (V_{SD}). Three curves are shown for $T_A = 125^\circ\text{C}, 25^\circ\text{C}, -55^\circ\text{C}$ at $V_{GS} = 0V$. The current increases with V_{SD} and is higher at higher temperatures. The y-axis is logarithmic.</p>

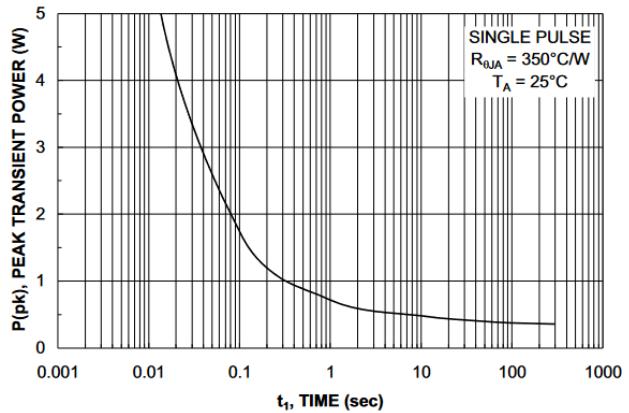
Typical characteristics



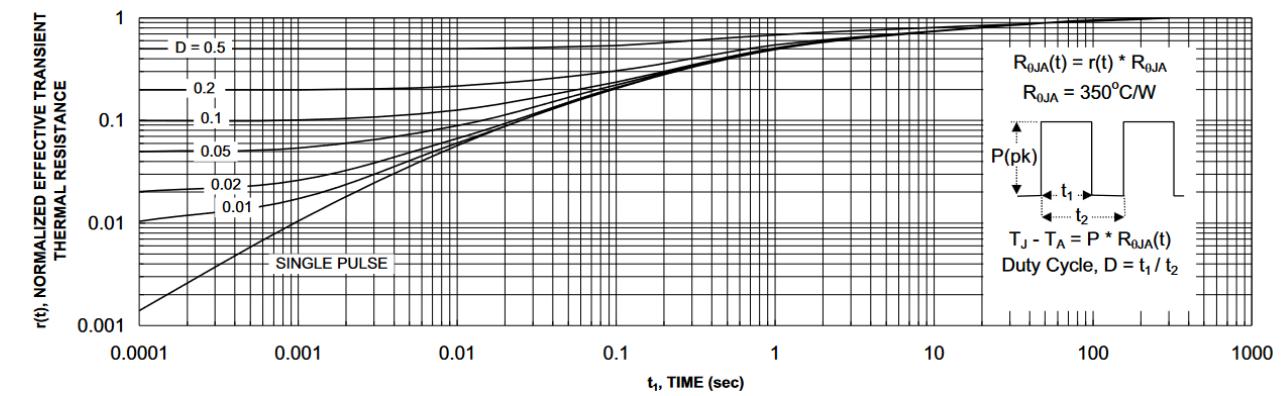
Maximum safe operating area

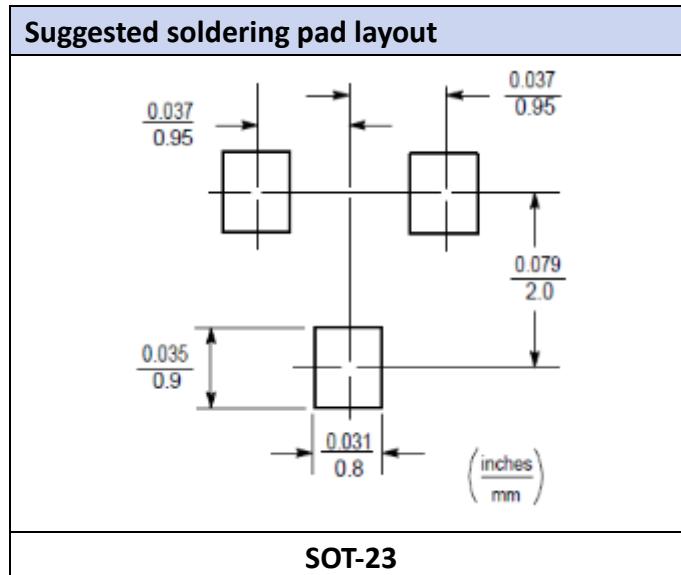


Single pulse maximum power dissipation



Normalized effective transient thermal impedance





Ordering information			
Part Number	Package	Shipping Quantity	Dimensions
BSS123	SOT-23	3000 pcs / 7" reel	---

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